



IFW

DOCKET: FIS920030146US1

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

INVENTOR: Stephen W. Bedell et al.)
SERIAL NO.: 10/604,989)
FILING DATE: August 29, 2003) DATE: November 10, 2004
FOR: AN ELECTRON MICROSCOPE MAGNIFICATION STANDARD
PROVIDING PRECISE CALIBRATION IN THE MAGNIFICATION
RANGE 5000X – 200,000X

AMENDMENT UNDER RULE 312

Mail Stop Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Responsive to the Notice of Allowance mailed October 14, 2004, please amend the application as follows:

In the Title

Delete the title and replace it with the following:

- - AN ELECTRON MICROSCOPE MAGNIFICATION STANDARD PROVIDING
PRECISE CALIBRATION IN THE MAGNIFICATION RANGE 5000X – 200,000X - -